

Notice of References Cited	Application/Control No. 10/501,192	Applicant(s)/Patent Under Reexamination NAGAHAMA, HIROSHI	
	Examiner James A. Dudek	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,741,298	05-2004	Won, Se Chang	349/58
	B	US-6,667,780	12-2003	Cho, Chun-Hyun	349/58
	C	US-6,583,831	06-2003	Kim, Tae-Joon	349/58
	D	US-6,549,263	04-2003	Kim, Hyo-Jin	349/58
	E	US-6,515,721	02-2003	Jin et al.	349/58
	F	US-6,177,971	01-2001	Jung et al.	349/60
	G	US-6,166,788	12-2000	Ha et al.	349/58
	H	US-6,016,175	01-2000	Kim, Sung Kon	349/58
	I	US-5,838,400	11-1998	Ueda et al.	349/58
	J	US-6,600,526	07-2003	Yano, Takakazu	349/65
	K	US-6,690,435	02-2004	Ha et al.	349/61
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.